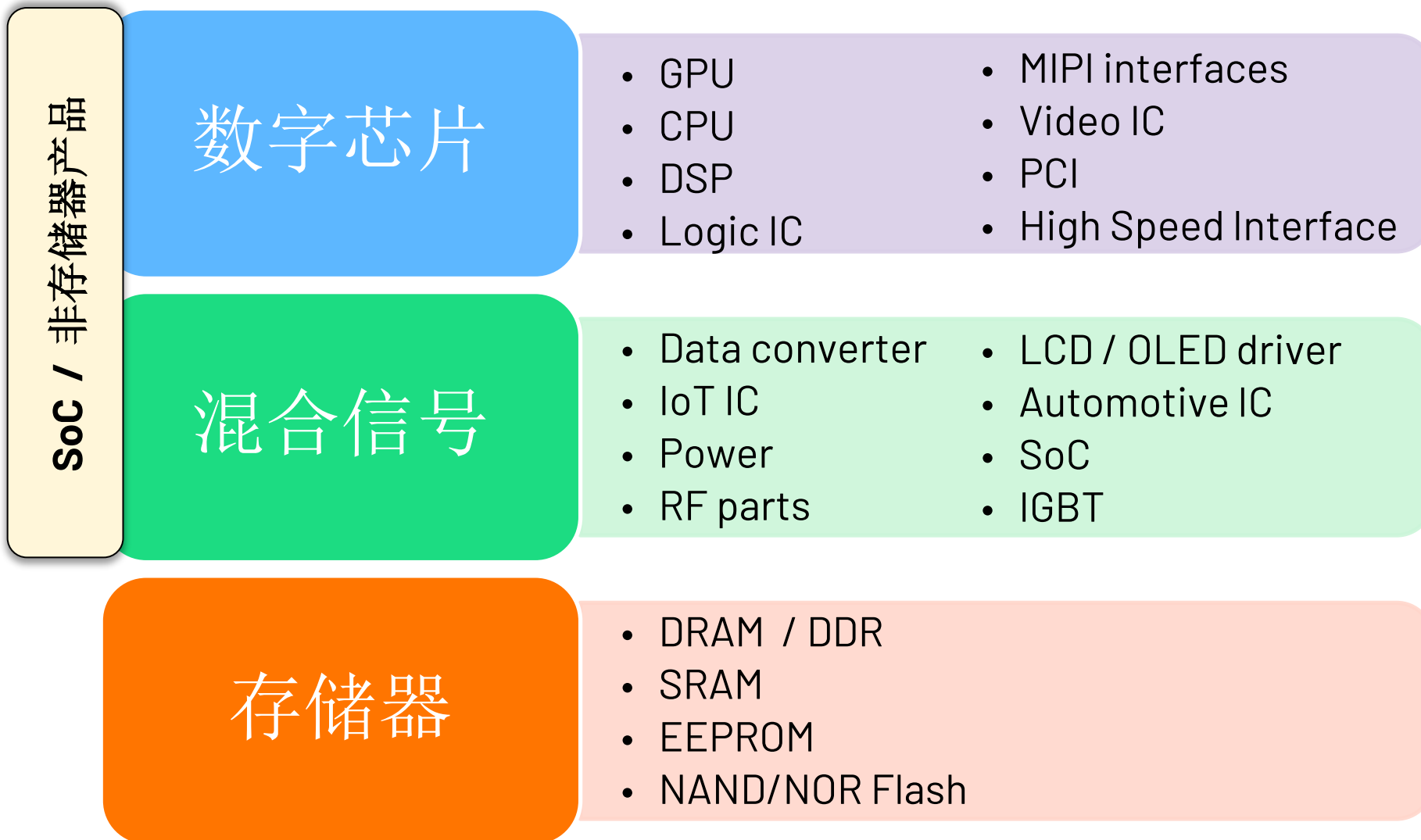


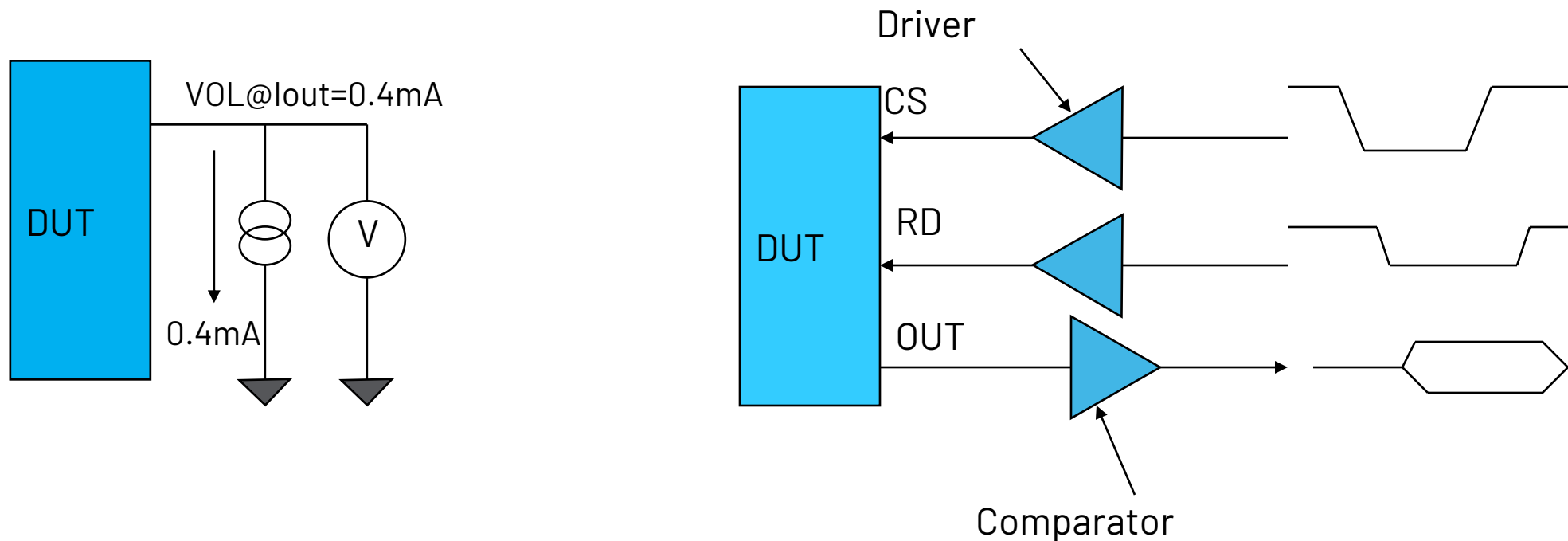
ADI助力半导体自动测试 设备—ATE产品介绍

蔡振宇/黄健杰

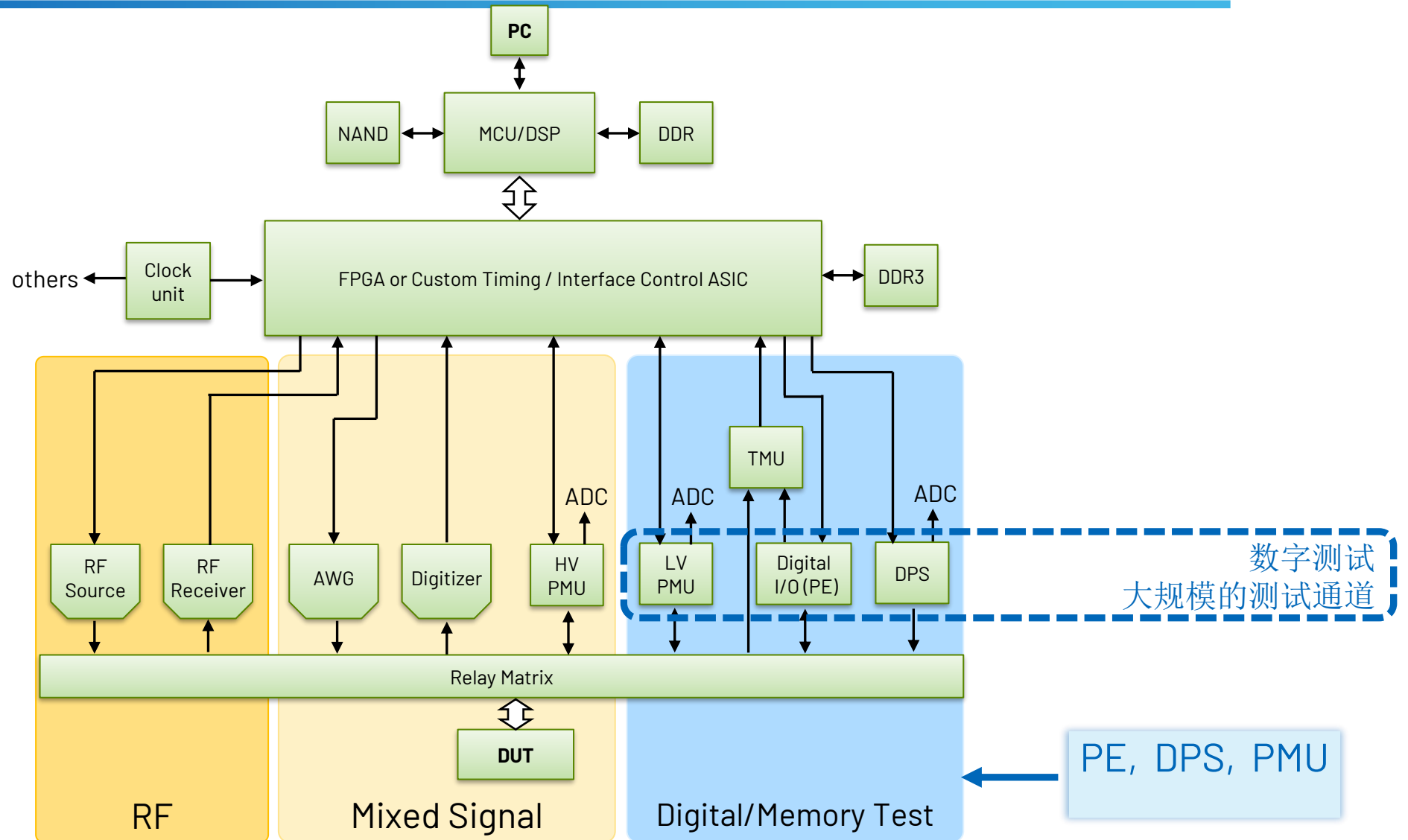
- **ATE设备市场**
- ADI ATE ASSP 产品介绍
- ATE产品基础应用介绍
- 参考设计方案



- **功能测试:** 开路, 短路
- **直流参数测试:** V_{OH} , V_{OL} , I_{IH} , I_{IL} , 电源电压/电流
- **交流功能测试:** 读/写时序, 真值表, 建立时间/保持时间等



ATE系统



- ATE设备市场
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通常用于ATE术语

PE (Pin electronic)

- 用于产生和接收DUT的数字信号
 - 高时域精度
- 工作频率高
 - 10MHz–X GHz
- 每个测试机的通道多
 - 集成度高

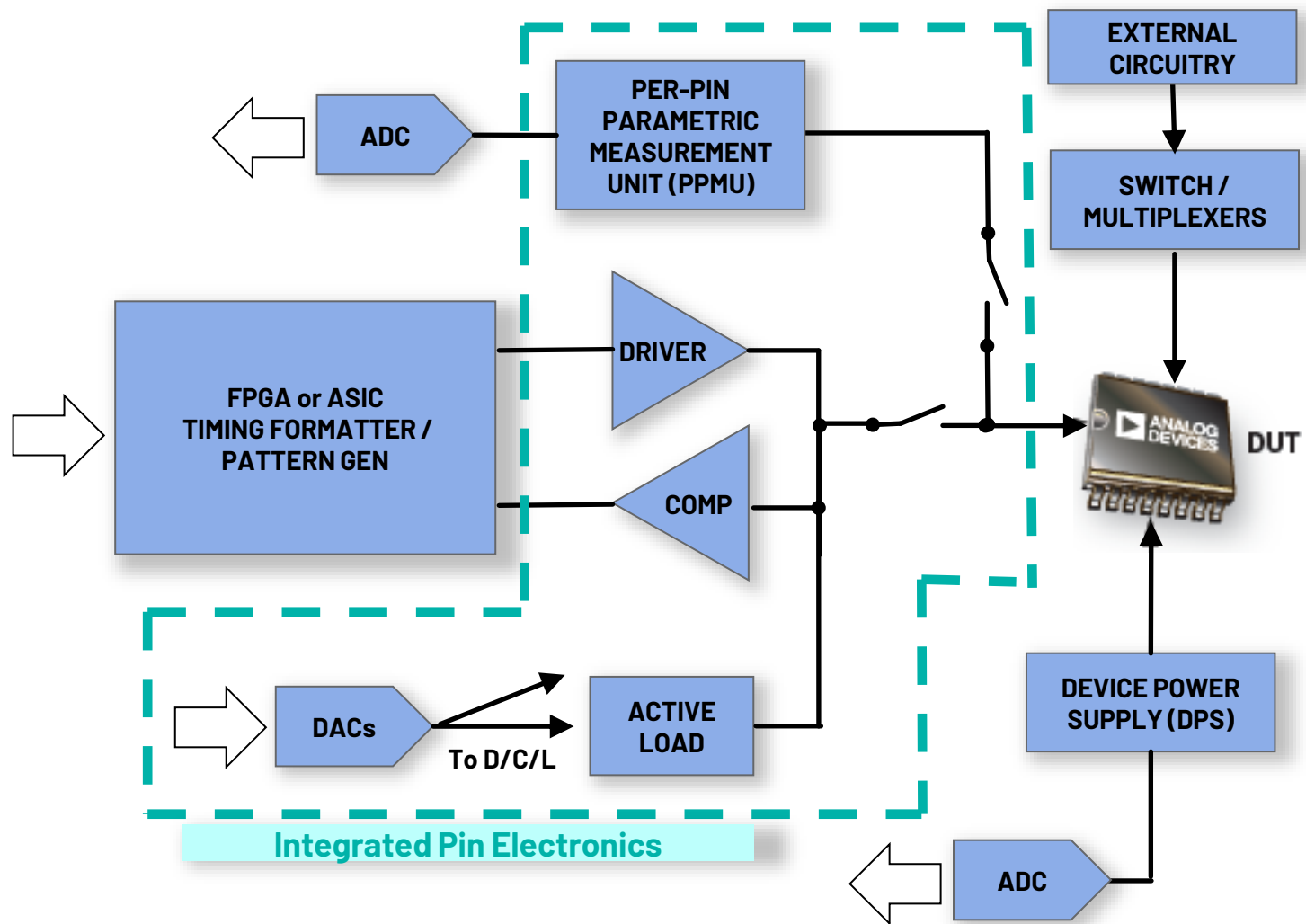
PMU (Parametric Measurement Unit)

- 用于输出和测量电压和电流
- 需要较高的测力和测量精度
- 电流范围高达100 mA
- 电压范围高达25V

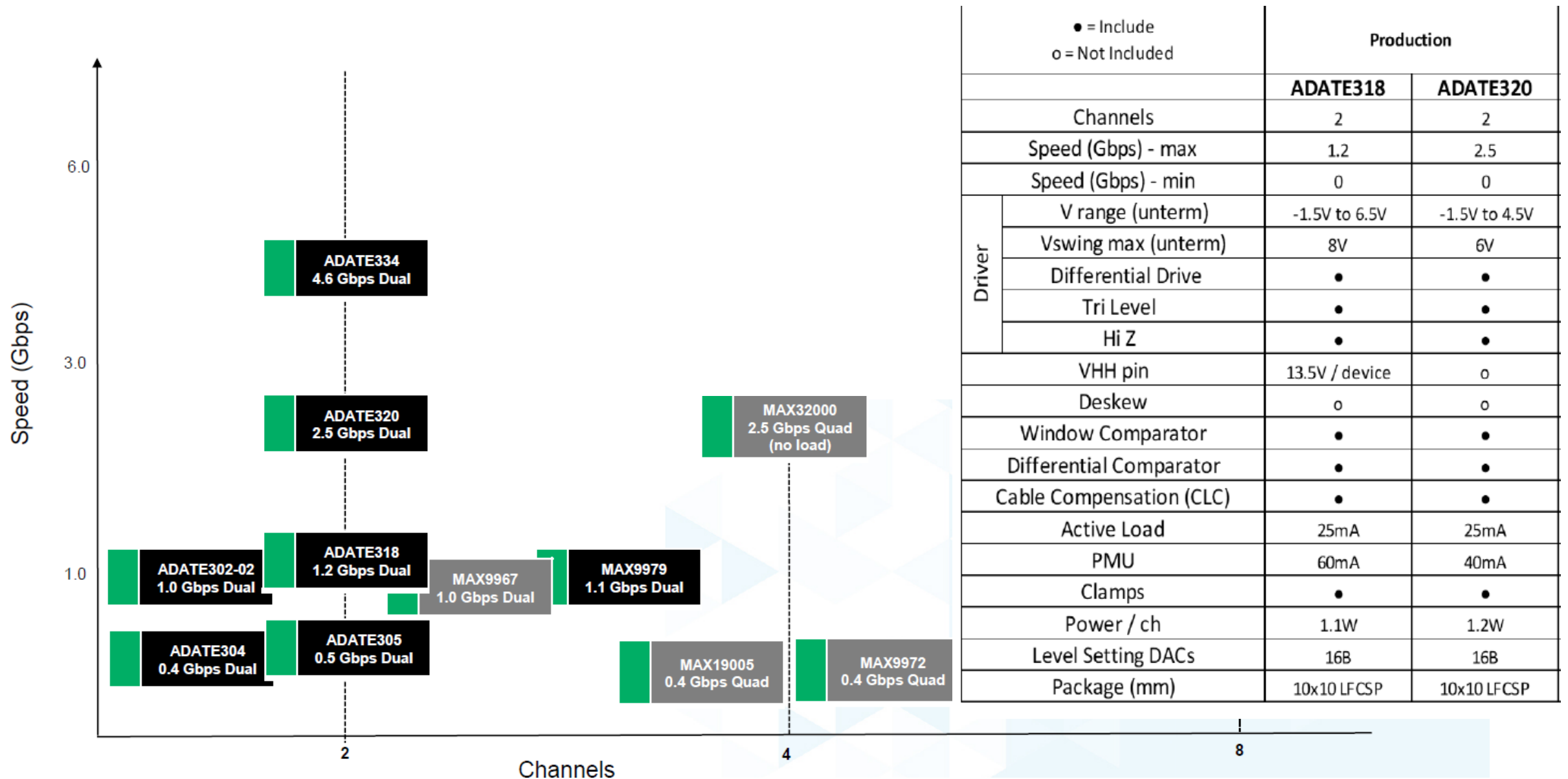
DPS (Device Power Supply)

- 对DUT (待测物) 提供可编程的电源
- 电压输出, 测量电流
- 需要良好的测量精度
- 电流范围: A级别
- 电压范围: 25V
- 更高的电流
- 稳定地驱动更高的电容负载

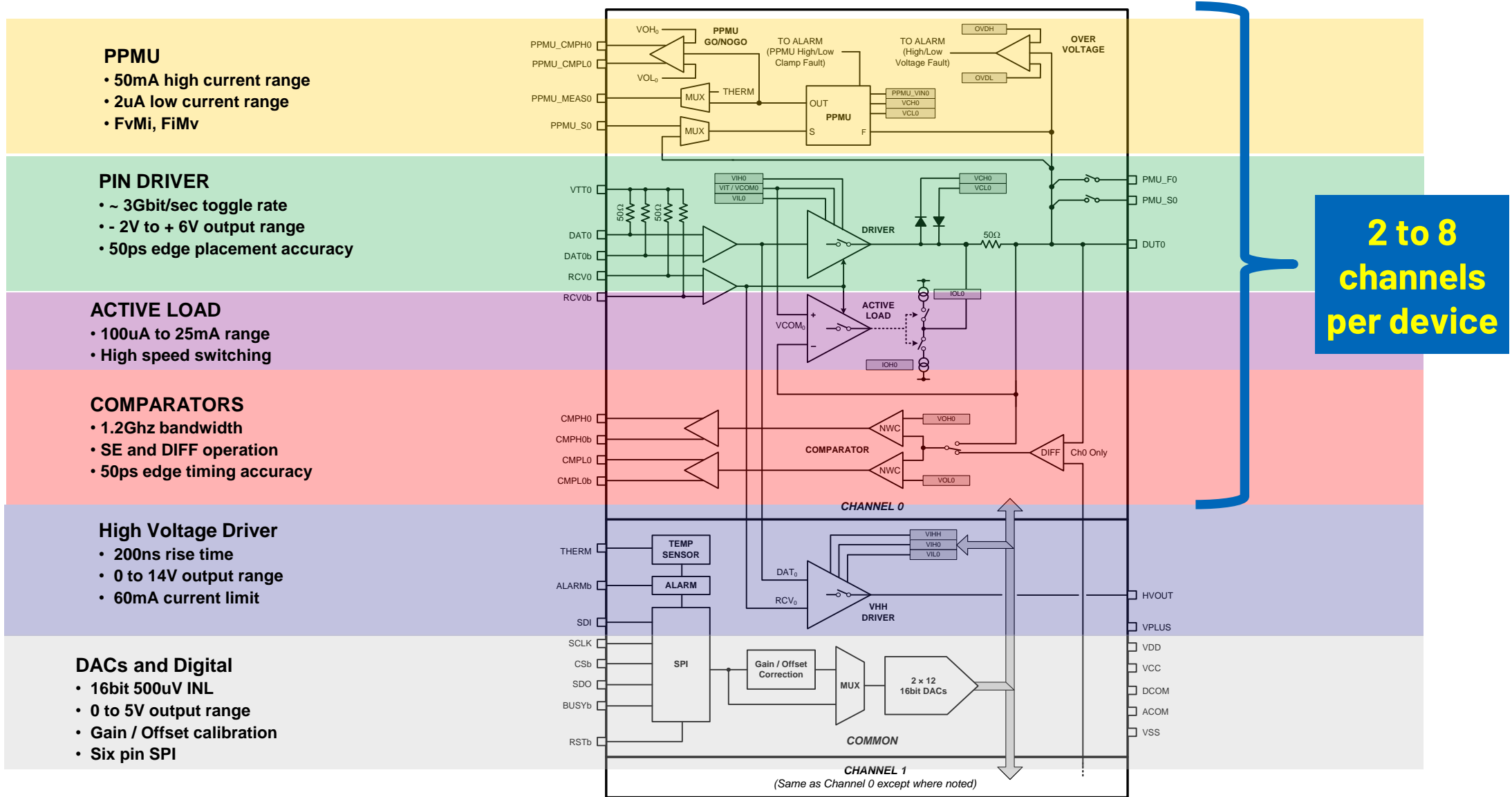
数字 I/O 信号链



PE roadmap



ADATE3xx 框图及参数



DSP/PMU road map

PMU

AD5522
Quad Channel
4 Ranges up to $\pm 2\text{mA}$,
 $\pm 80\text{mA Ext.}$, 22.5V Span

AD5520
Single Channel
4 Ranges up to $\pm 4\text{mA}$,
6mA Prog Ext., 22V Span

DPS

MAX32010
Single Channel
1.2A, 25V Span,
14x14mm TQFP

AD5560
Single Channel
1.2A, 25V Span,
8x8mm FcBGA

AD5560
Single Channel
1.2A, 25V Span,
12x12mm TQFP

MAX9959
Single Channel
800mA, 25V Span,
14x14mm TQFP

AD5522(PMU)框图

▶ 四通道PMU-4个独立通道

- 电压或电流
- 满量程电流范围5uA至80mA
- 满量程电压范围为-16.25V至+ 22.5V

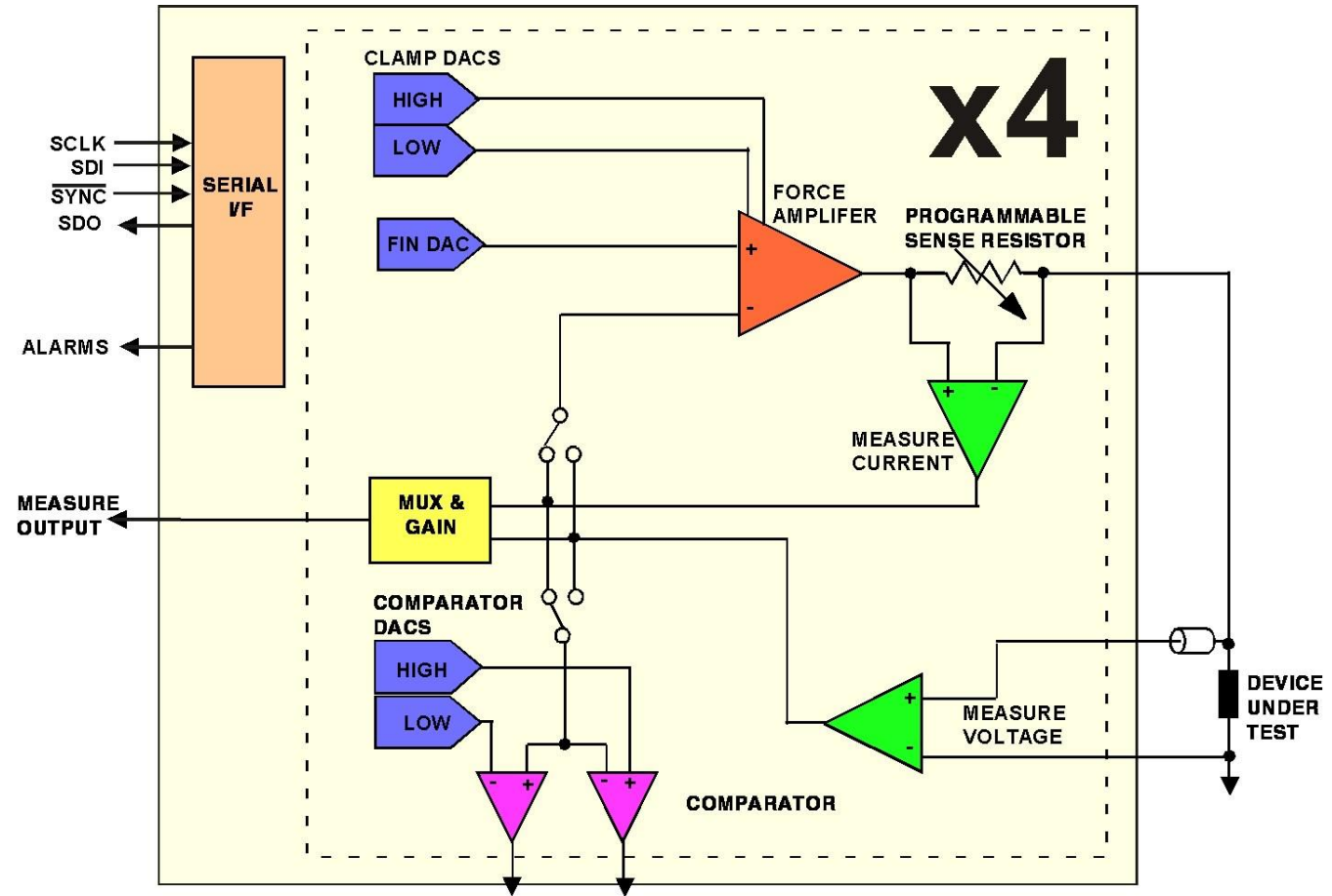
▶ 集成测量电压和电流的仪表放大器

▶ 比较器，用于比较V或I

▶ 钳位电路在输出电流模式下限制电压

▶ 每个通道5个DAC，总共20个DAC

- 1用于设置输出电压或电流
- 2个用于高/低压钳位
- 2个用于高/低比较器
- 用户针对增益和失调进行校准



AD5560(DPS)框图

► 高集成度并可提供精确的电压

■ FV/MI 功能

- 输出电压跨度: 25V, 可扩展+可偏置
- 5 档电流范围:
 - 5 uA, 25uA, 250uA, 2.5mA, 25mA (Rsense on-chip)
- 2 档高电丁输出
 - 500mA and 1.2A max (Rsense off-chip)

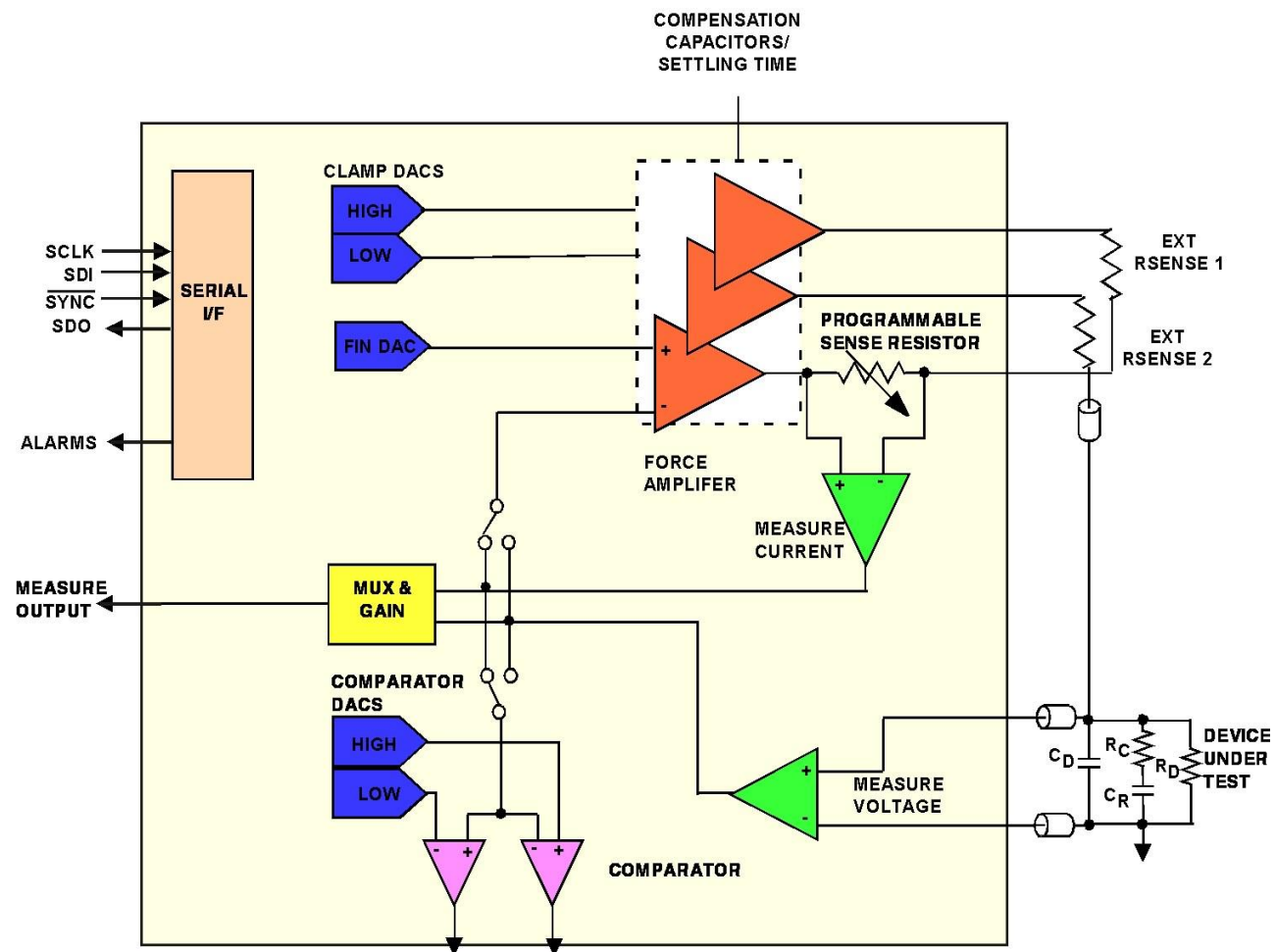
■ 测量电压功能

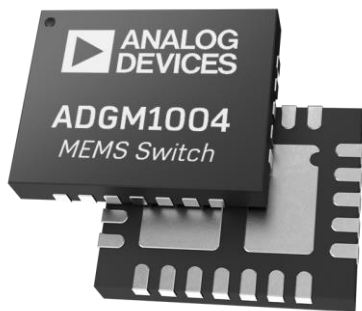
- 用于测量待测物电压

■ 片上偏置及增益校准

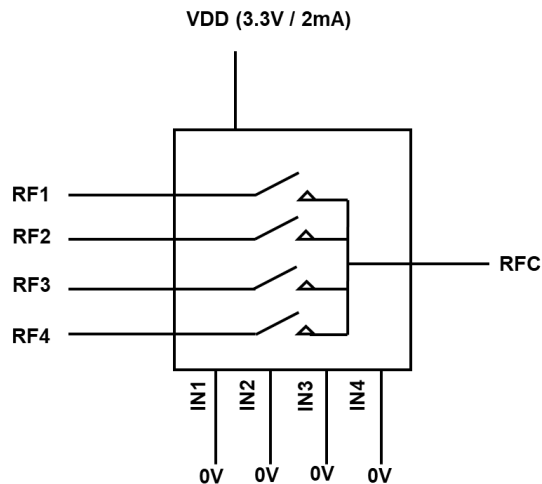
■ 工作模式

- 输出电压/测量电流
- 支持并联输出





ADGM1004
0 Hz/DC to 13 GHz, SP4T
2.5 kV HBM ESD



DC + Wide Bandwidth
20x Smaller SP4T
Relay Replacement



在 ATE 中使用 MEMS 开关的好处

特点

可用范围 DC 至 13GHz 高频

SP4T 更小封装尺寸 (5x4x0.95mm)

10 亿次循环寿命

3.3V 易于使用的电源

Benefits

通过单程测试提高测试效率

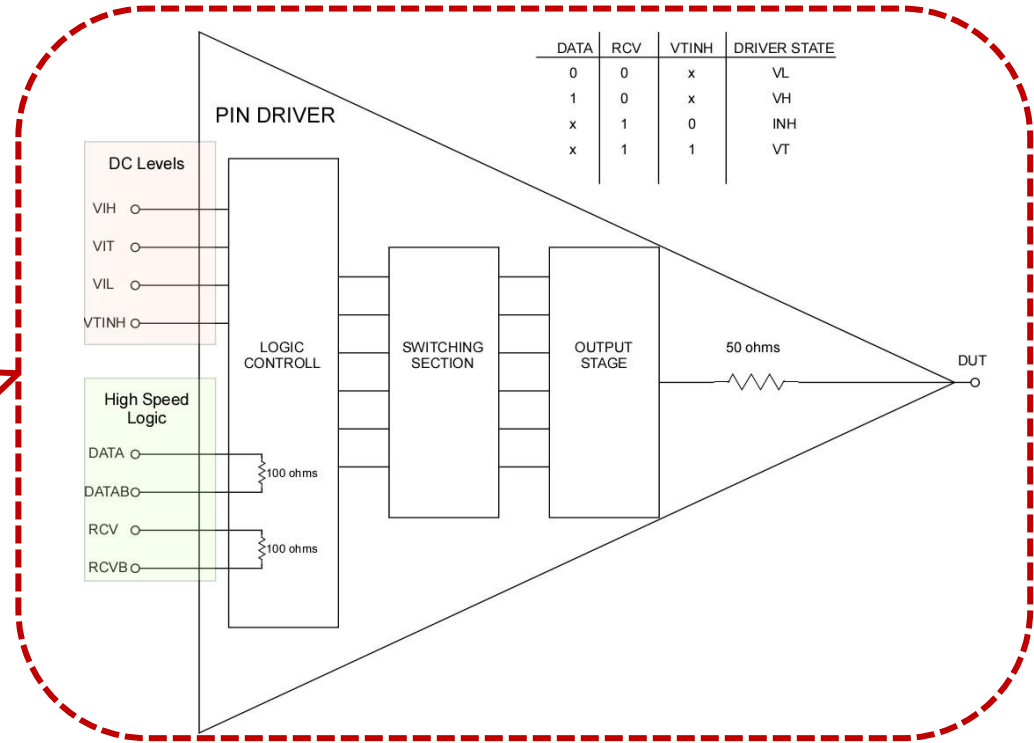
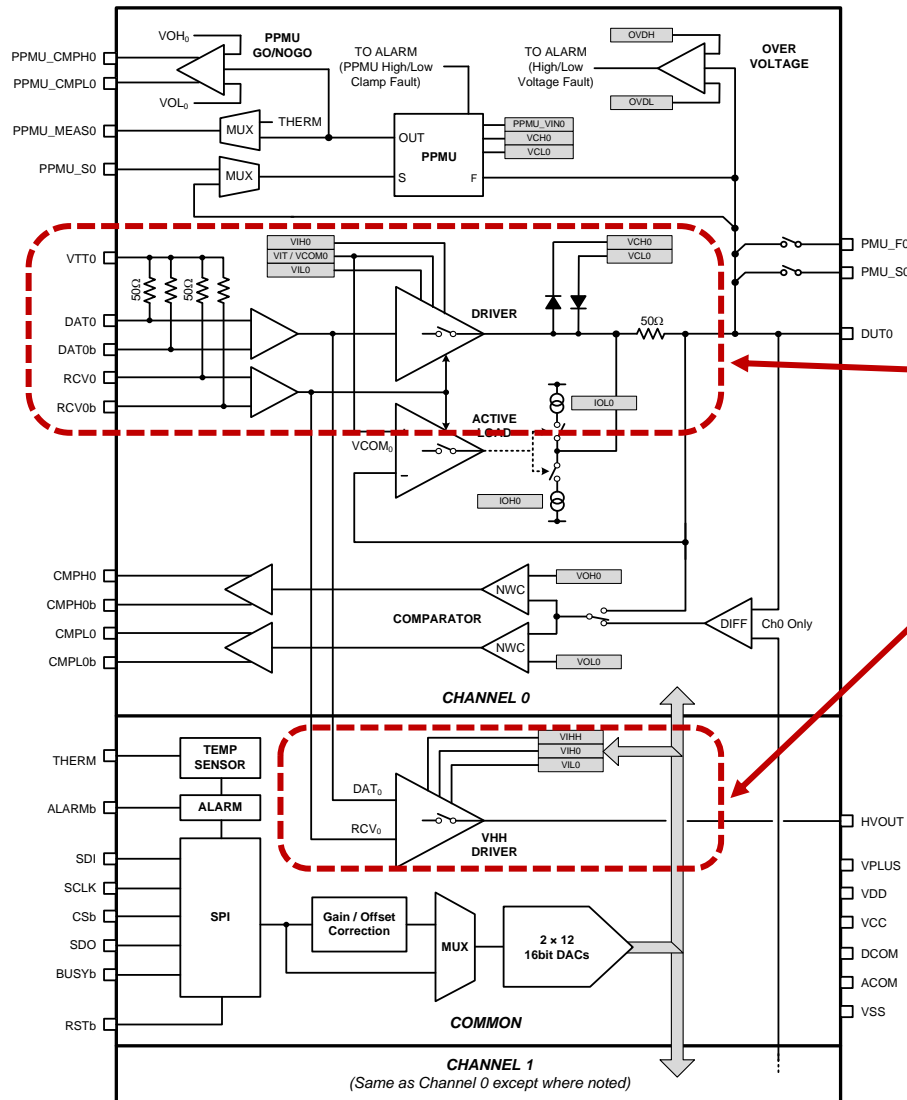
增加每个测试板的 DUT 和测试功能

提高系统可靠性

简化解方案实施

- ATE设备市场
- ADI ATE ASSP 产品介绍
- **ATE产品基础应用介绍**
- 参考设计方案

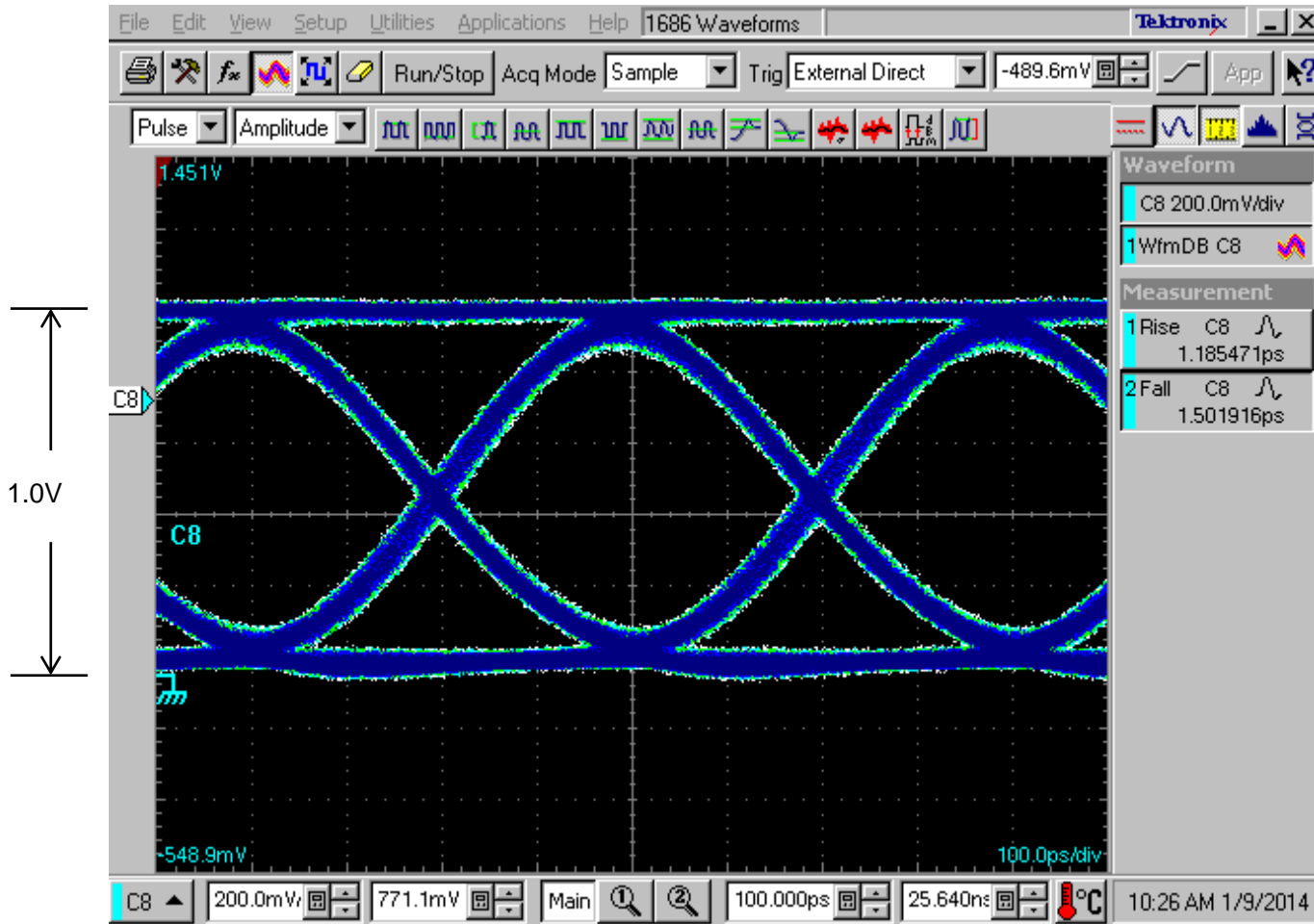
数字pattern发生器---ADATE320 Driver



Function of Driver

- Output Level Setting
- High Analog Performance
- Clamp function

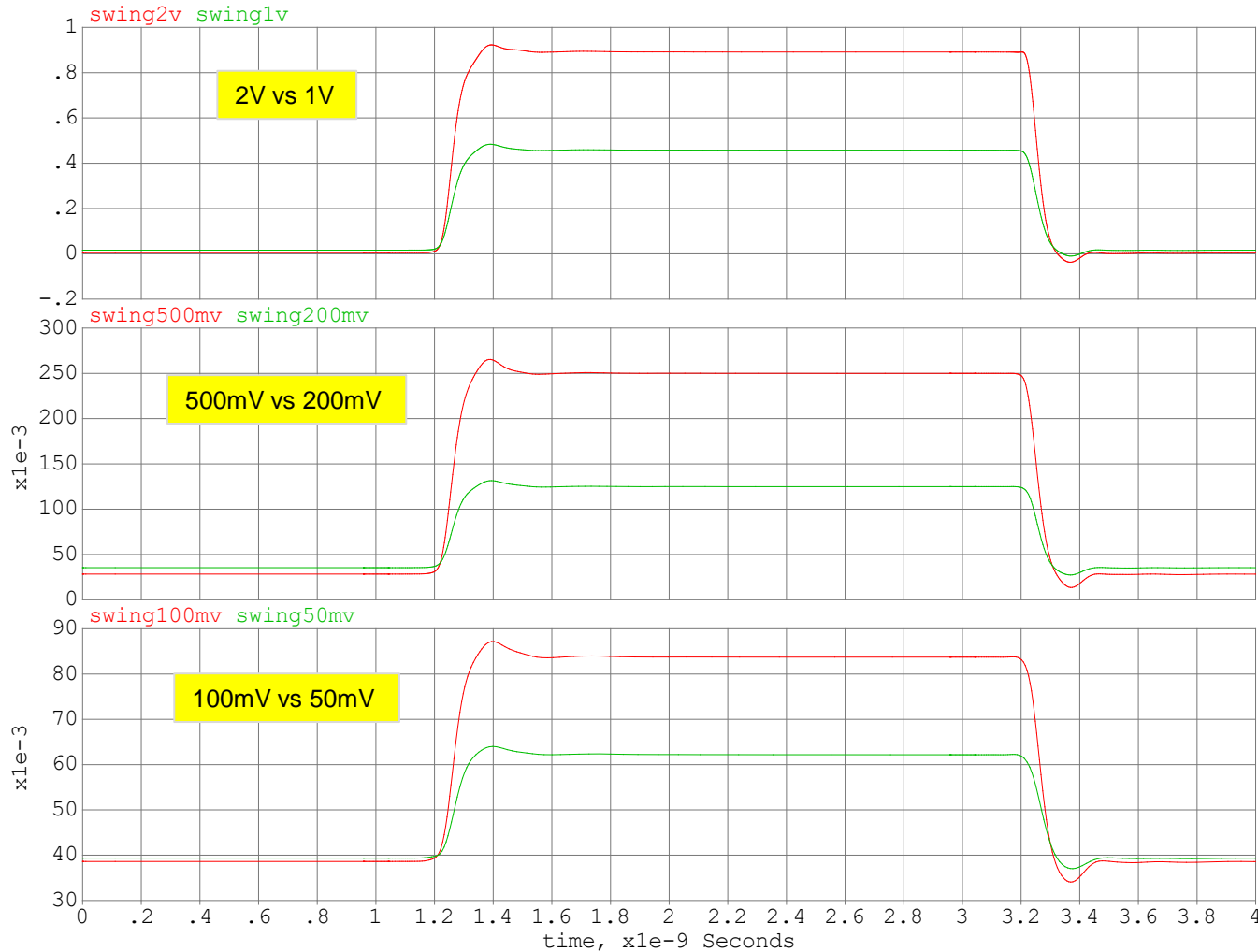
Driver Eye Diagram 2.5Gbps PRBS 2³¹-1, 2.0V prog



Driver Eye Diagram

- Clear eye: Good jitter performance
- Good SI: No special overshoot and distortion.

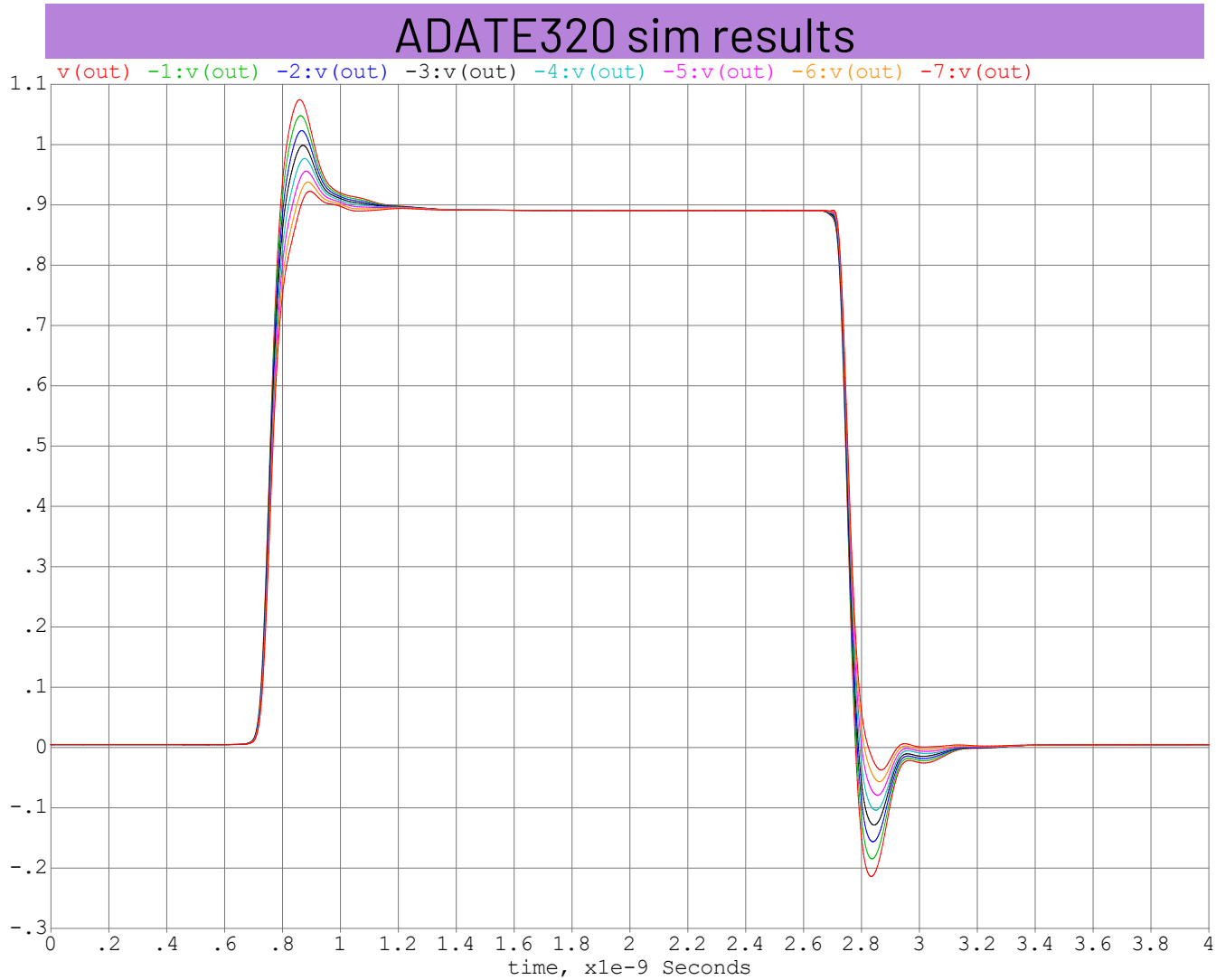
ADATE320 sim results



Function of Rise/Fall Edge

- Fidelity : Keep same performance at different Amplitude output.
- Don't concern about rise/fall time change at different situation.

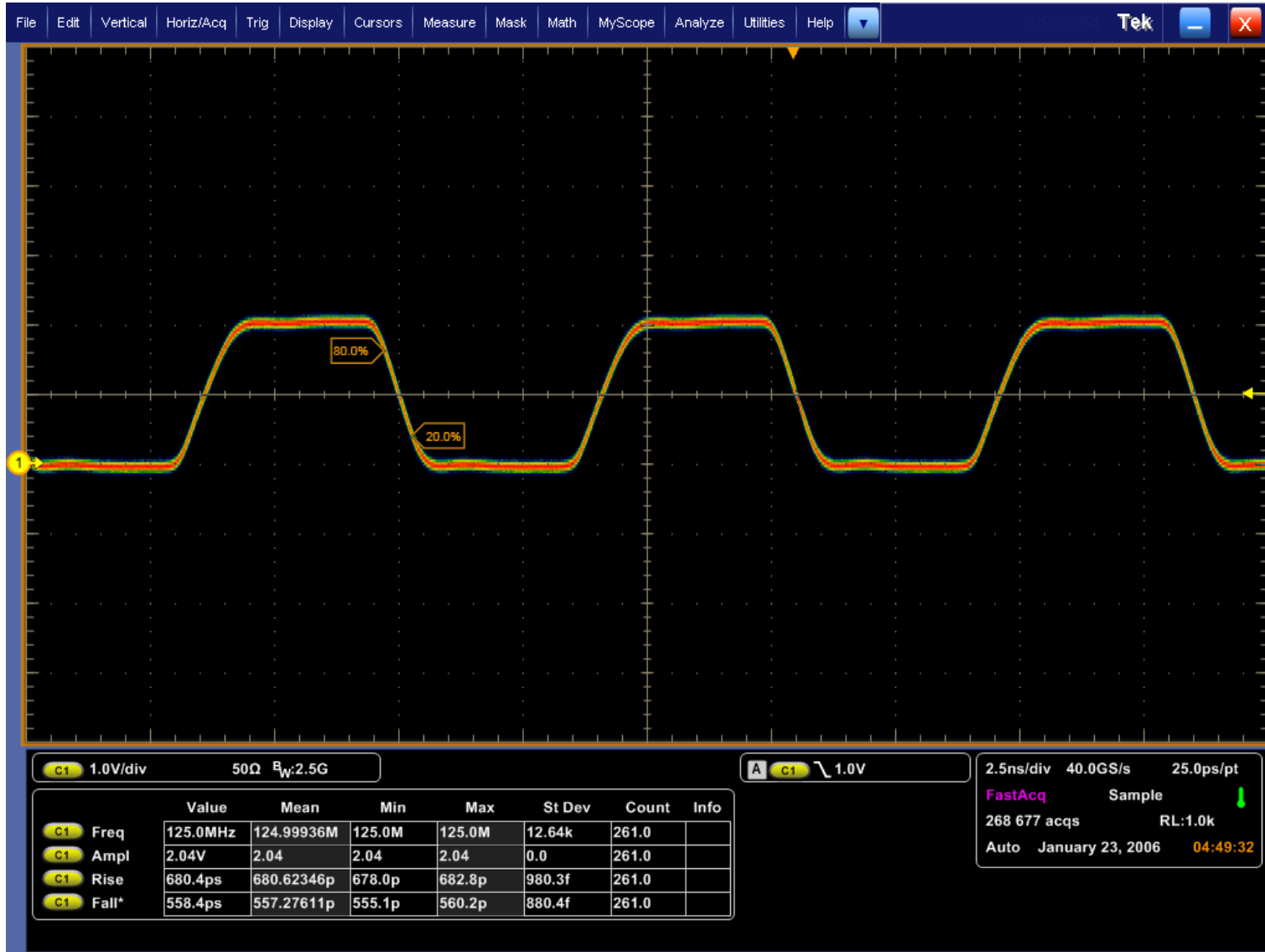
数字pattern发生器--- Pre-Emphasis (CLC)



Function of Driver CLC

- Cable loss compensation
- SI adjustment
- Balance overshoot and rise/fall time

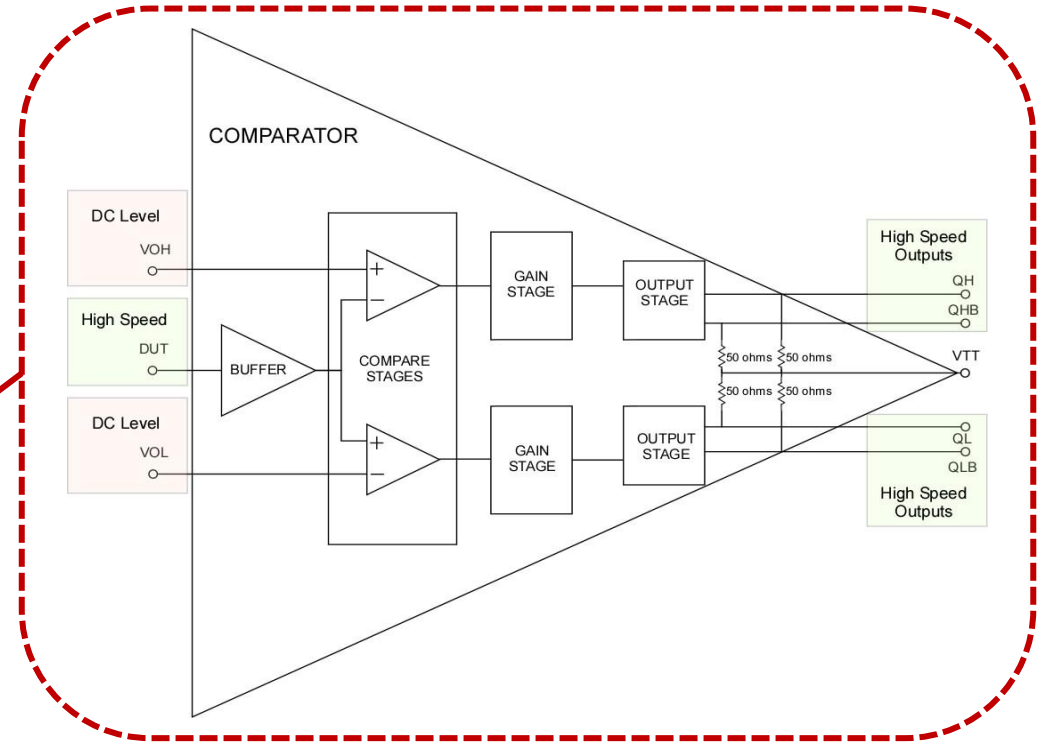
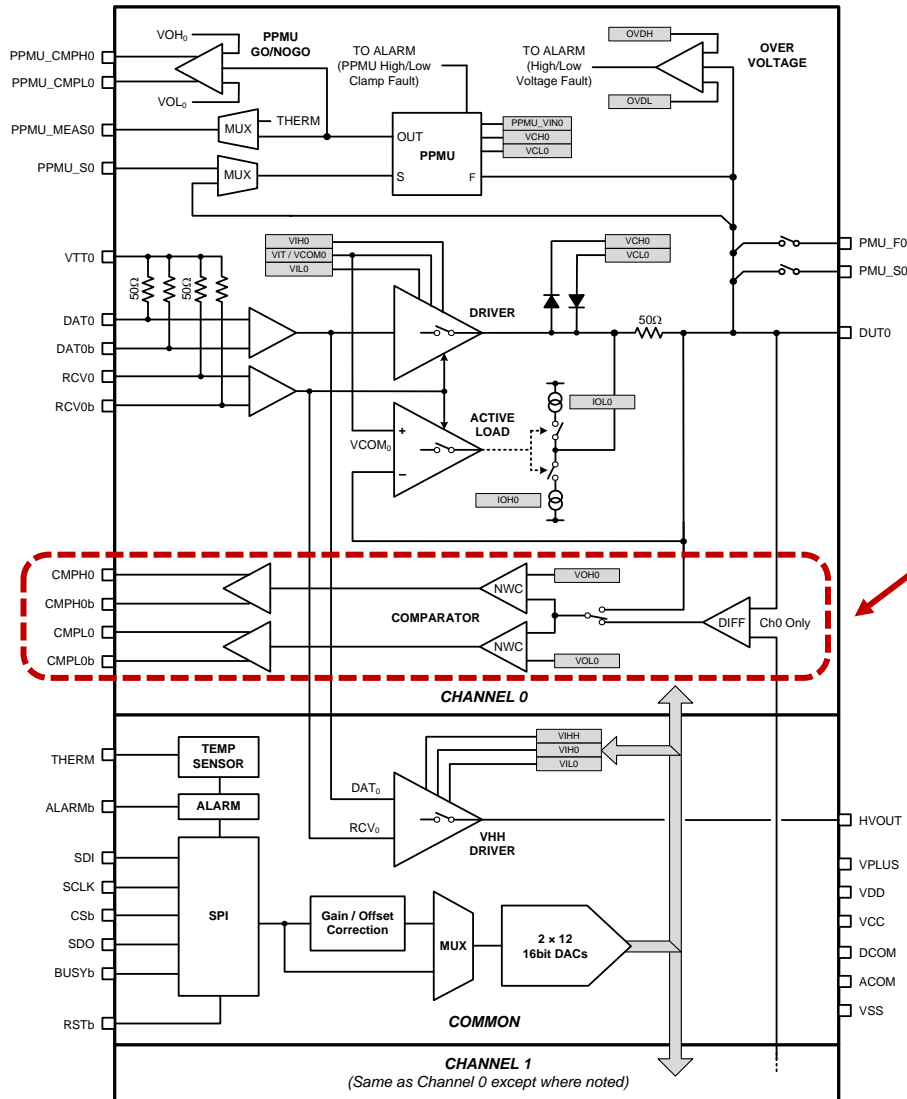
ADATE318 LV Driver 测试



测试环境:

1. VIH: 4V
2. VIL: 0V
3. Frequency: 125MHz
4. CLC: off
5. Load: 50ohm
6. Scope: 2.5G BW
7. Cable: RG316 1m
8. RLC Band stop filter: added

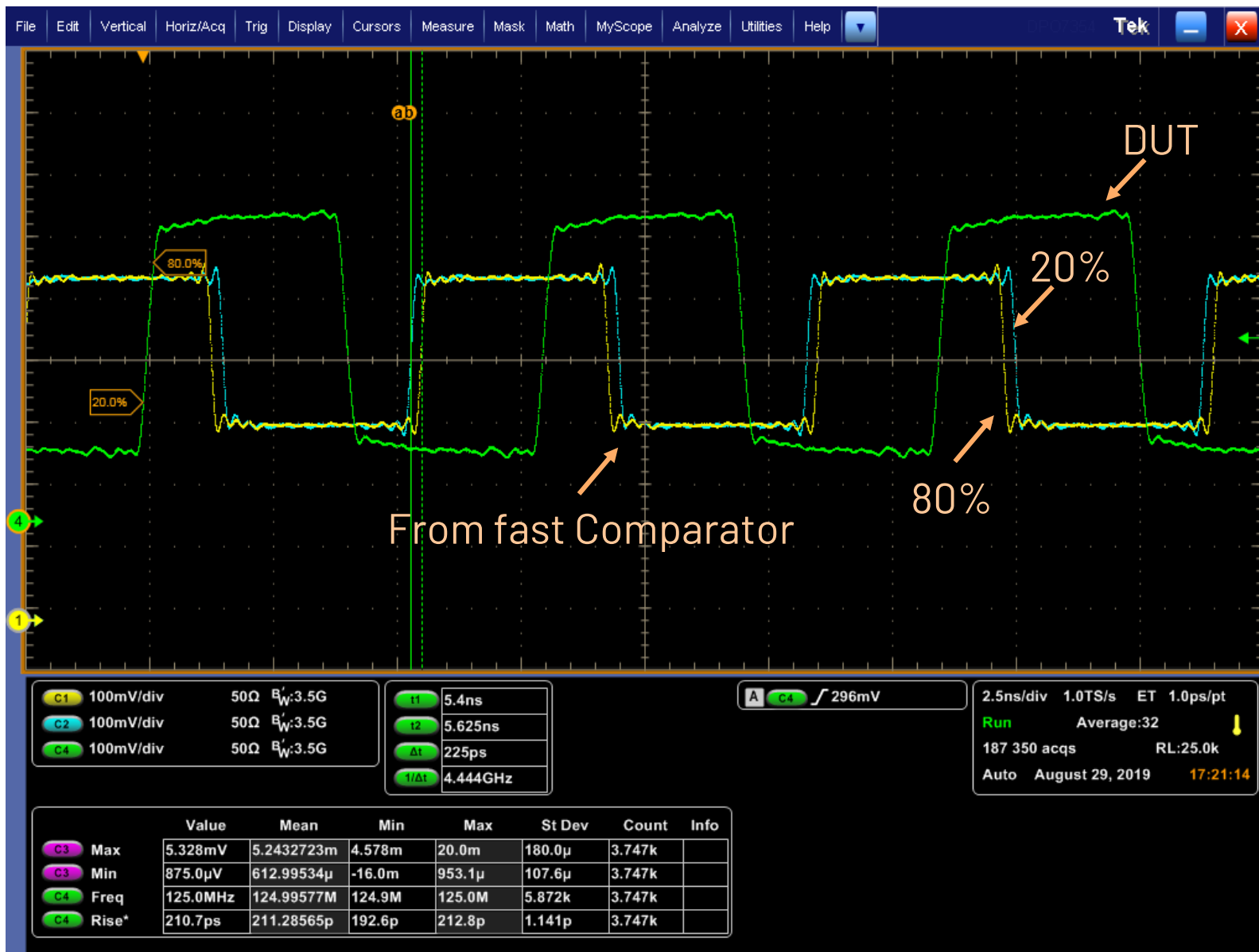
ADATE3xx --- 比较器



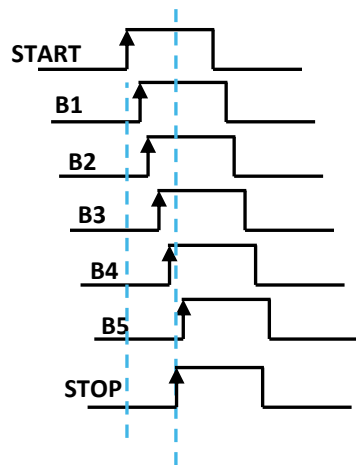
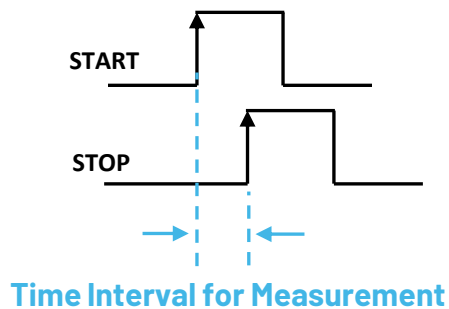
Function of Comparator

- 2 triggered signal for TMU
- Level conversion
- DC voltage pass/fail

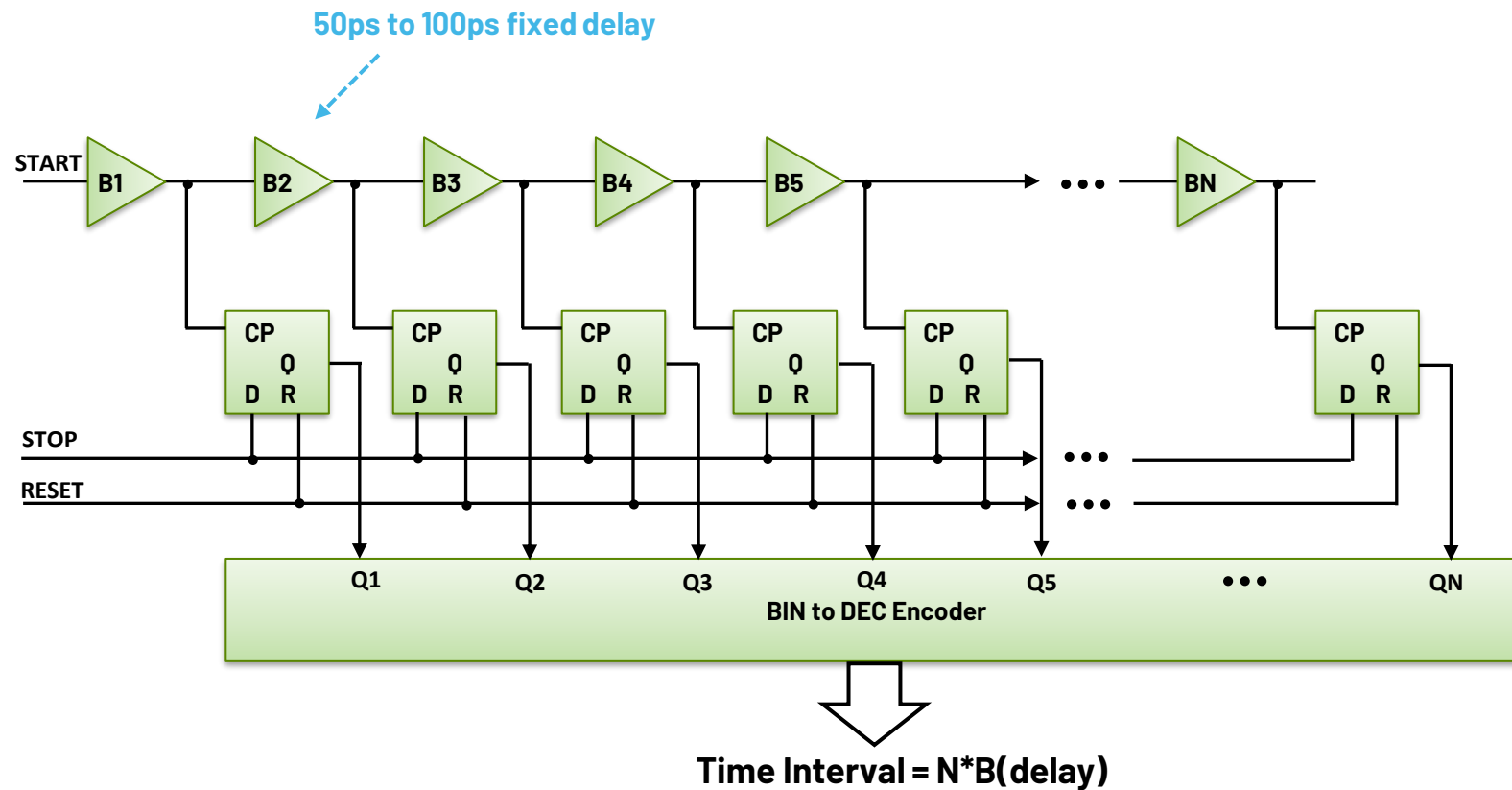
样例 ---- Rise/Fall Edge 测试



时间测量单元--- Digital Time Encoder in FPGA



Interval Q = 000011111...

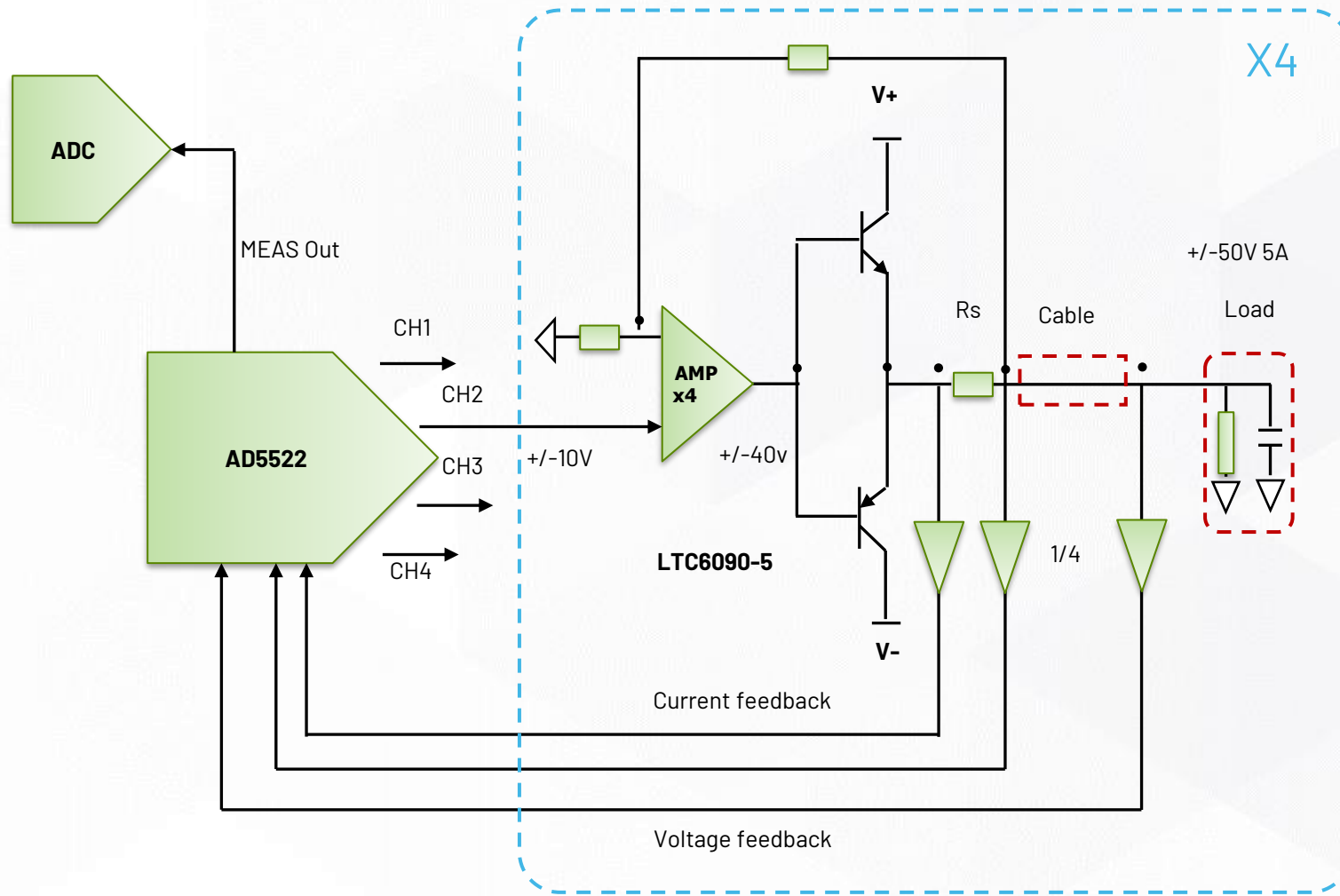


Notes:

- 1) Edge of signal is not sharp enough in FPGA, it cause jitter and uncertainty.
- 2) Temperature cause gate uncertainty.
- 3) Must add constraint and map to fixed area of FPGA.

- ATE设备市场
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- ATE产品基础应用介绍
- 参考设计方案

高功率范围 DPS/SMU 解决方案



主要特点:

支持4象限V / I

AD5522支持4ch DPS / SMU

电压: +/- 50V

电流: 5A

最小化DC / DC纹波

支持脉冲输出 (高带宽)

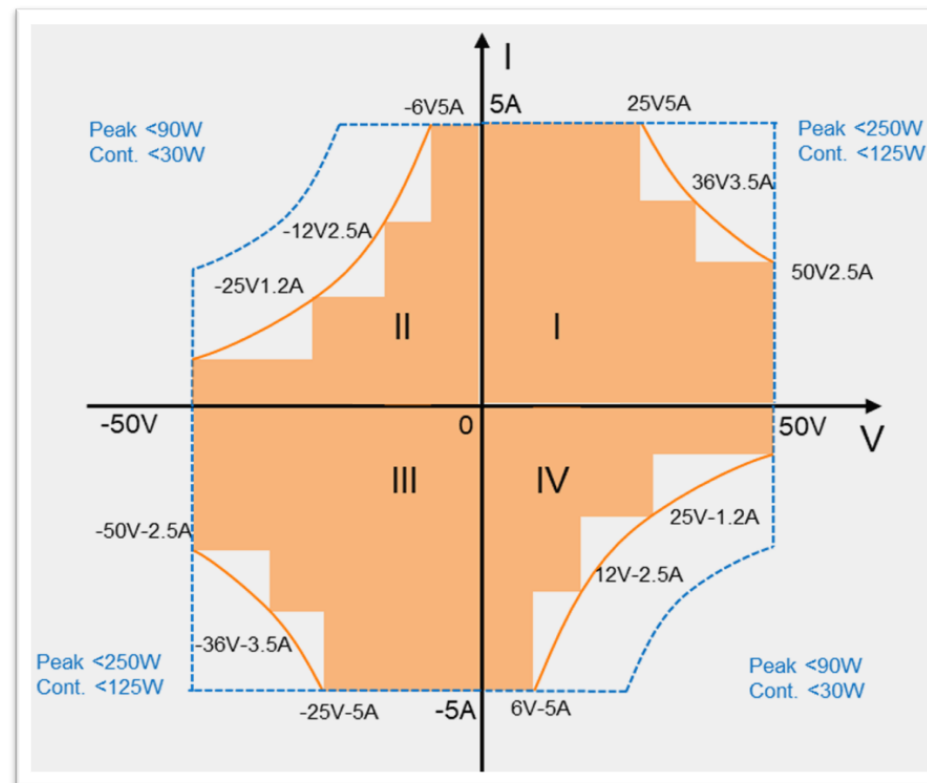
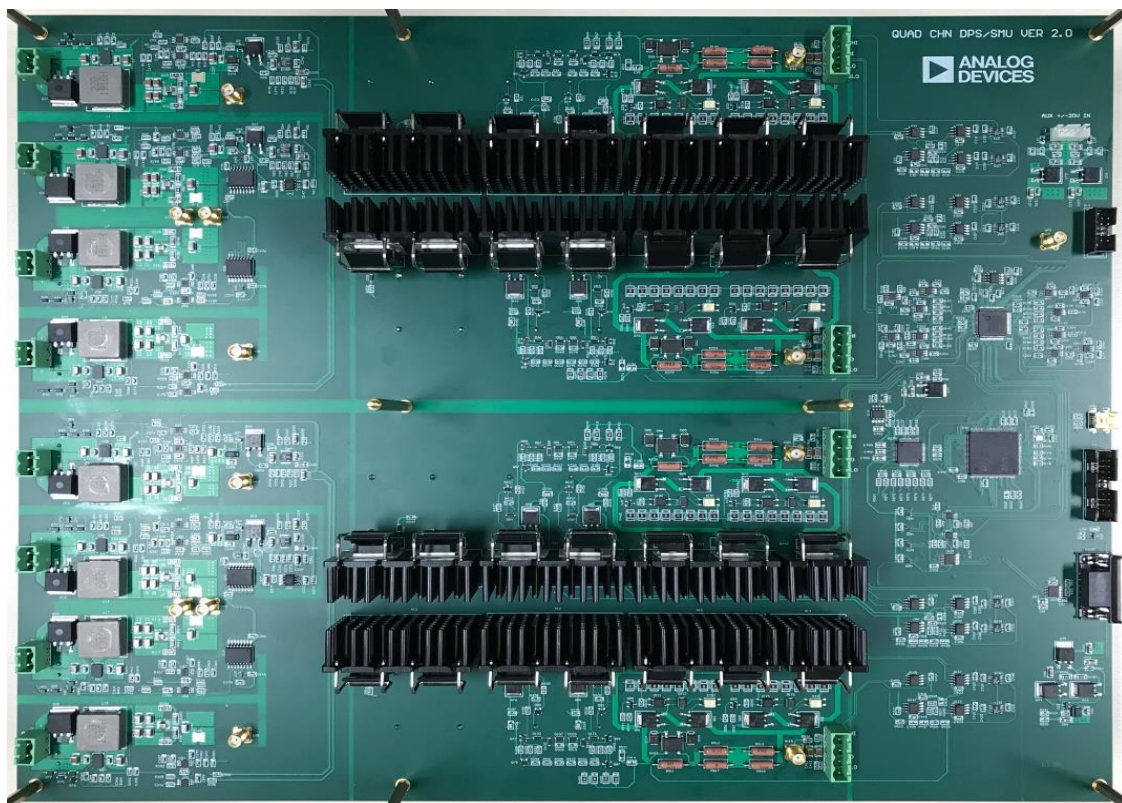
浮动输出 (非通道间)

片上电压/电流钳位保护

片上电压/电流窗口比较器

与整体线性驱动器相比, 效率更高

支持可编程增益V / I测量

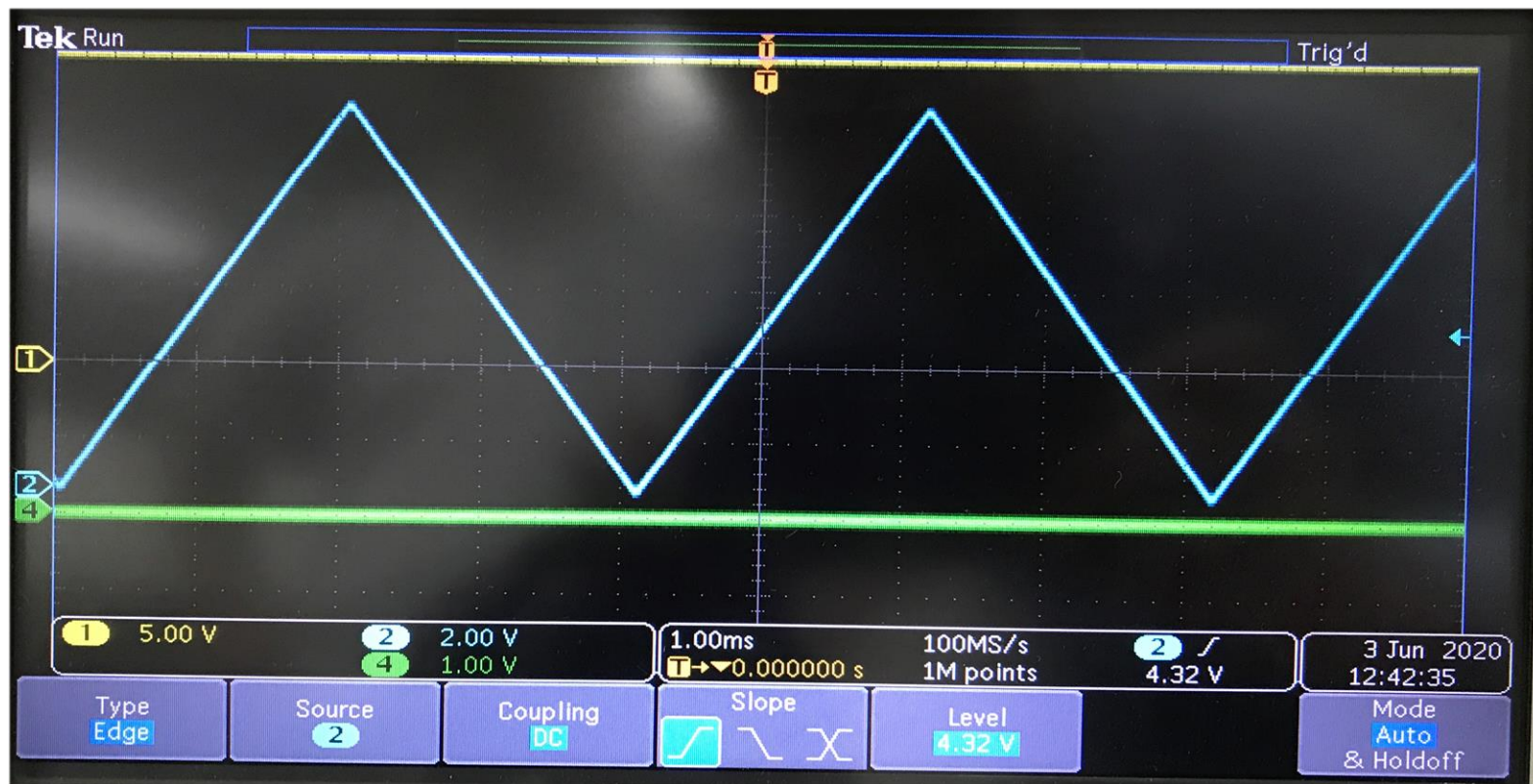


4 quadrants

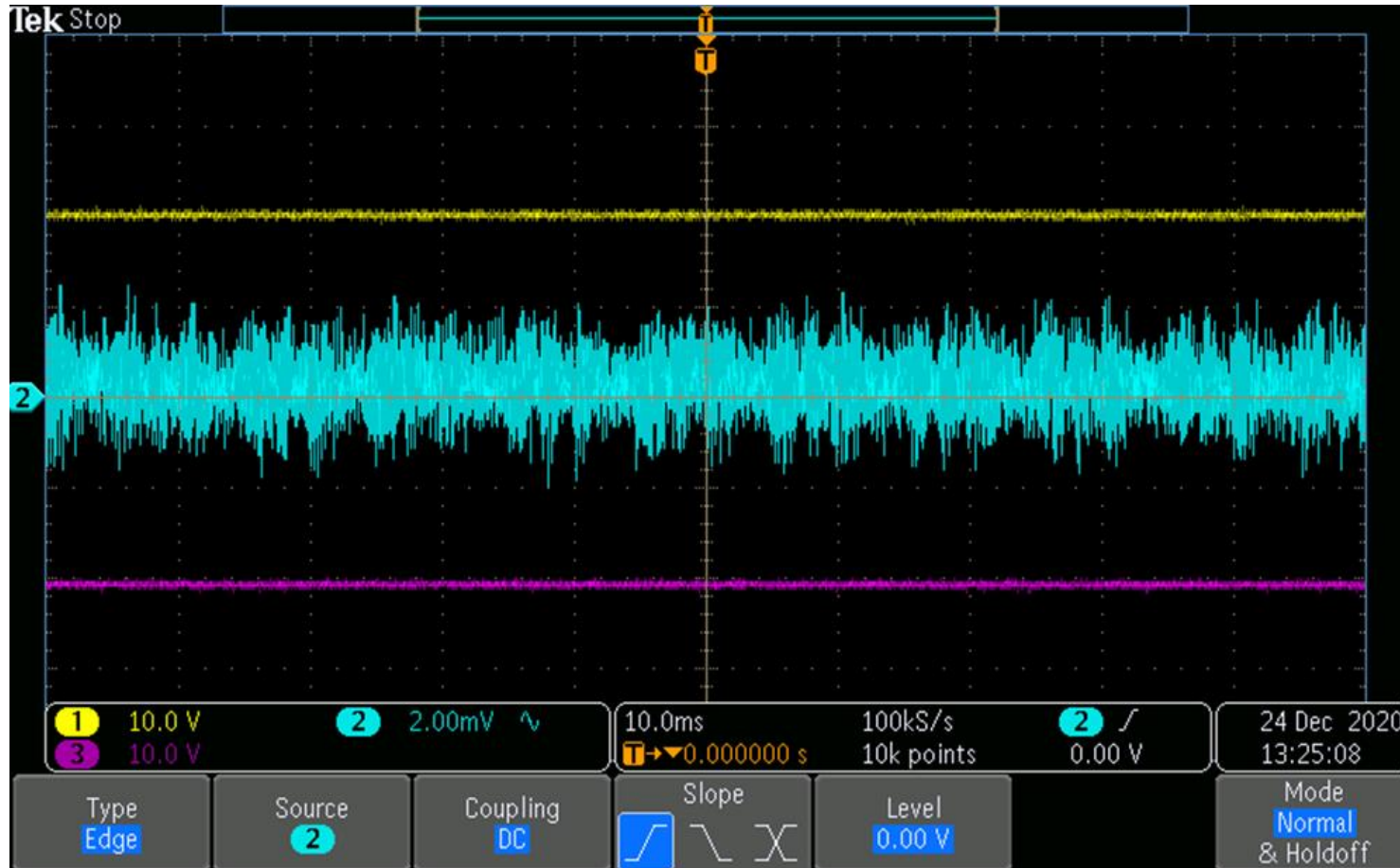
Max 250W per Channel

+/-50V 5A x4 Channels

FV扫描输出波形



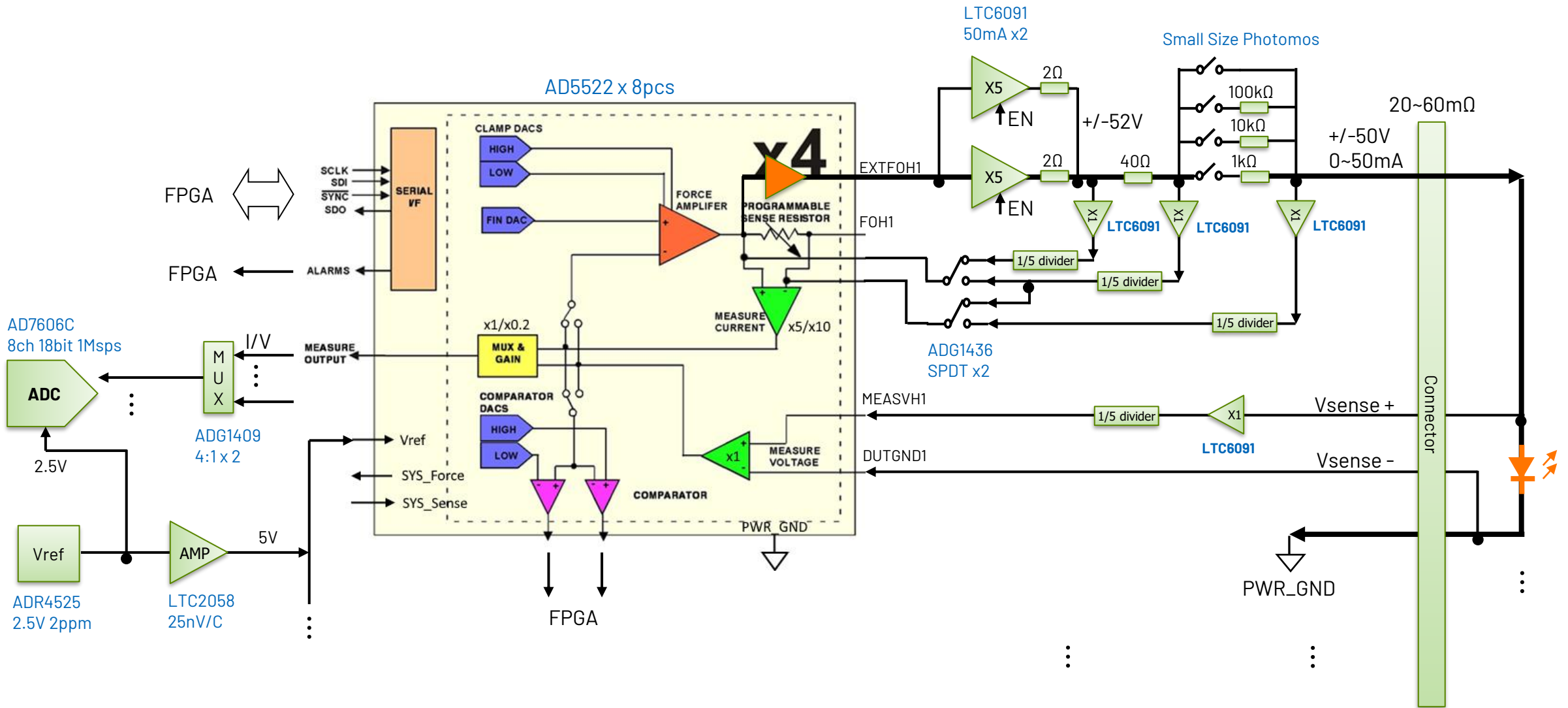
FV 模式--- 噪声性能, $V_0=+/-10V$



Red - positive main
Blue - SMU output
Yellow - negative main

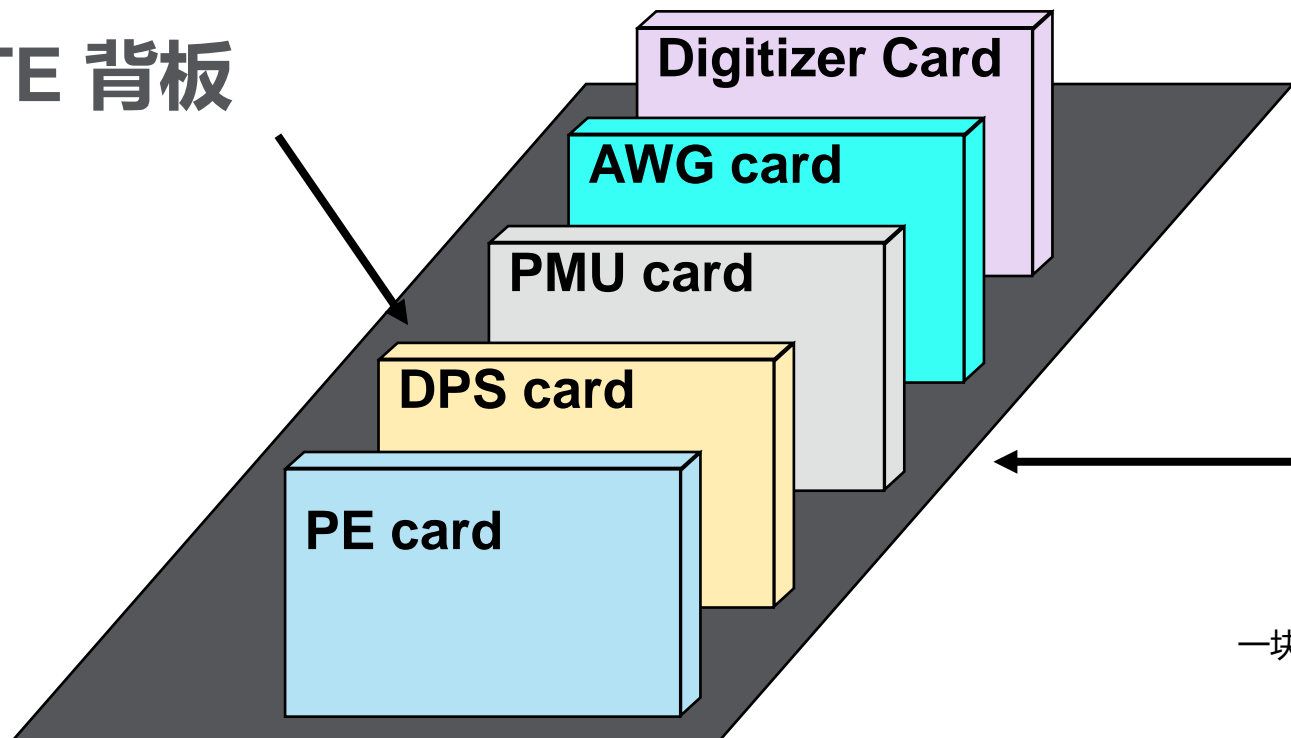
10nF compensation
5A current range
10uF + 10ohm load

32CH SMU Block Diagram --- +/-50V 50mA



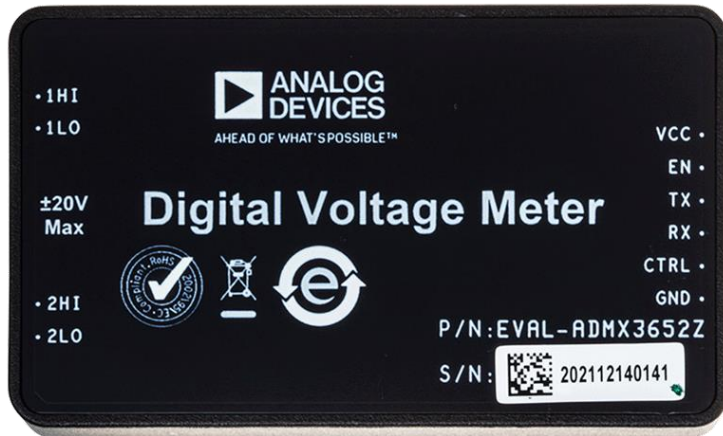
ATE使用中的小困扰

ATE 背板



一块用于校准ATE卡的校准板

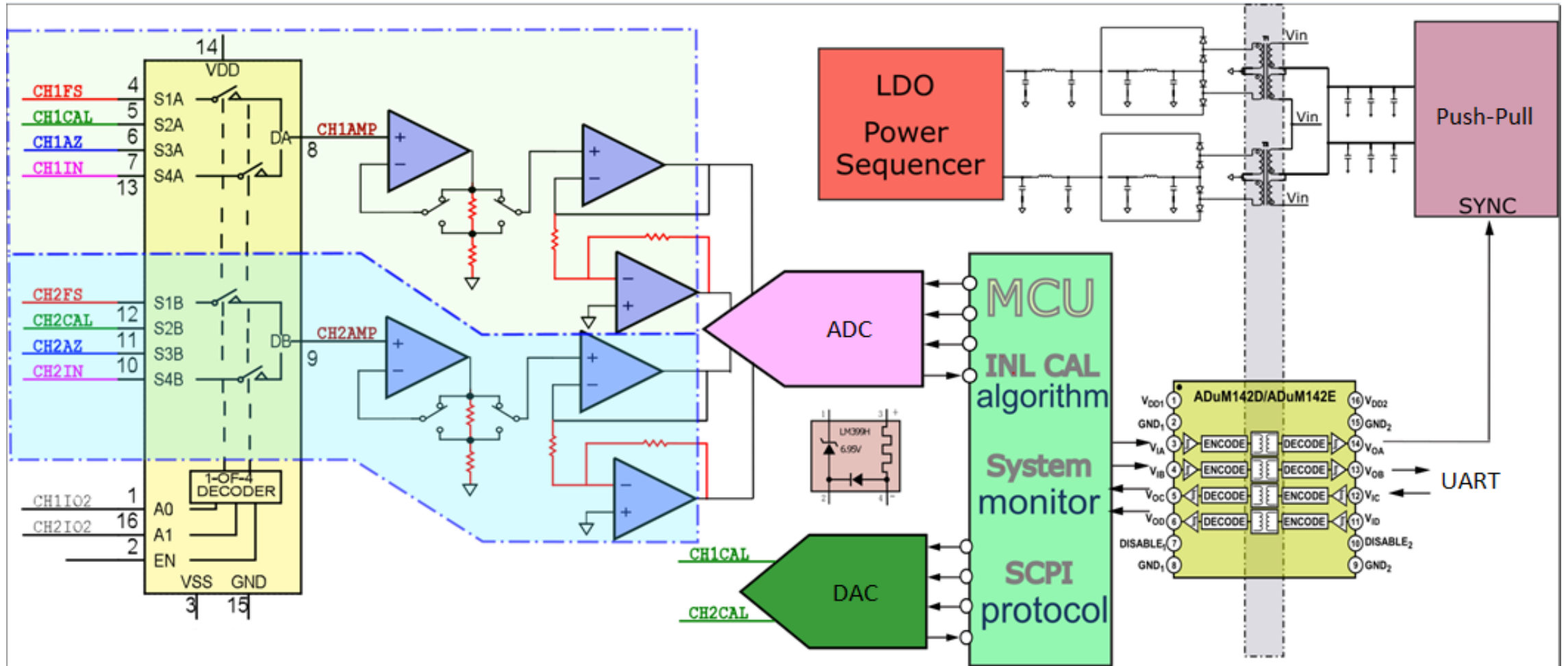
6.5 DVM模块



Application:

- ATE
- BFT
- ICT / FCT Test
- Small Signal Test
- Precision voltage/current measurement

6位半DVM解决方案（超高精度电压DAQ模块）



主要功能

- ▶ 双通道
- ▶ 精准度
 - 自动归零和满量程校准
 - 同步开关电源
- 高速
 - 最高10ksps数据速率
- 健壮性
 - 隔离电源和数字接口
 - 电源序列和监控器, 输入保护
 - 信号链诊断
- 易用性
 - 5V电源, UART接口
- ▶ 兼容性
 - 支持SCPI协议
 - 扩展的模拟输入通道
 - 输出高精度基准电压

DC 参数

- ▶ 范围: $\pm 20\text{ V}$, $\pm 2\text{ V}$, $\pm 0.2\text{ V}$
- ▶ 90 days Accuracy (+/-3 Sigma, cover 99.7%)
 - $\pm 20\text{ V}$ Range: 12ppm + 4ppm
 - $\pm 2\text{ V}$ Range: 17ppm + 8ppm
 - $\pm 0.2\text{ V}$ Range: 98ppm + 40ppm
- ▶ 1个PLC时0.3 ppm rms噪声, 1000点
- ▶ 超低增益漂移
 - 保证0.5ppm /°C
- ▶ 超低漂移
 - 自动归零功能
- ▶ 高输入阻抗和低漏电流
 - 输入偏置电流 < 1nA @ 25°C
 - $\pm 20\text{ V}$, $\pm 2\text{ V}$ > 10G Ω
 - $\pm 0.2\text{ V}$ > 300M Ω

AD5522: https://www.analog.com/media/cn/technical-documentation/data-sheets/AD5522_cn.pdf

AD5560: https://www.analog.com/media/cn/technical-documentation/data-sheets/AD5560_cn.pdf

ADATE318: https://www.analog.com/media/cn/technical-documentation/data-sheets/ADATE318_cn.pdf

ADATE320: https://www.analog.com/media/cn/technical-documentation/data-sheets/ADATE320_cn.pdf

Thanks

